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# Enhanced efficiency of inverted polymer solar cells by using solution-processed $TiO_x/CsO_x$ cathode buffer layer

Xiaodong Zhou<sup>1\*</sup>, Xi Fan<sup>2</sup>, Xianke Sun<sup>1</sup>, Yunli Zhang<sup>1</sup> and Ziqiang Zhu<sup>1</sup>

#### Abstract

In this work, a double-buffer film of TiO<sub>x</sub> coated with CsO<sub>x</sub> (TiO<sub>x</sub>/CsO<sub>x</sub>) was solution prepared to be applied in poly (3-hexylthiophene):indene-C<sub>60</sub> bisadduct (P3HT:ICBA) and P3HT:[6,6]-phenyl-C<sub>61</sub>-butyric acid methyl ester (PCBM) inverted polymer solar cells (PSCs). Compared with TiO<sub>x</sub> films and CsO<sub>x</sub> films, the TiO<sub>x</sub>/CsO<sub>x</sub> double-buffer film exhibited a favorable energy-level alignment among TiO<sub>x</sub>, CsO<sub>x</sub>, and the electron acceptor of PCBM or ICBA a better surface morphology; and an enhanced wetting and adhesion property with a contact angle of 21.0°, leading to a higher electron mobility of  $5.52 \times 10^{-3}$  cm<sup>2</sup> V<sup>-1</sup>·s<sup>-1</sup>. Moreover, the P3HT:ICBA and P3HT:PCBM photovoltaic devices with the double-buffer film showed the best power conversion efficiency up to 5.65% and 3.76%, respectively. Our results not only present that the double-buffer film is superior than the single film of TiO<sub>x</sub> and CsO<sub>x</sub>, but also imply that the solution-processed film has a potential to be generally used in roll-to-roll processed organic photovoltaic devices.

Keywords: Inverted polymer solar cell; Solution processed; Cathode buffer layer

#### Background

Polymer solar cells (PSCs) have been a hot research topic due to their advantages of low cost, light weight, and large area [1-4]. Recently, normal (not inverted) PSCs with a considerable power conversion efficiency (PCE) of 7% ~ 9% have been reported [5-15]. In such normal PSCs, however, aqueous poly(3,4-ethylenedioxythiophene):poly(styrenesulfonate) (PEDOT:PSS) dispersion is acidic at pH 1 and corrosive to indium tin oxide substrates [16]; In addition, PSS and Al could diffuse into active layers and react with organic active layers [17]; therefore, instability of PSC devices caused by the anode buffer layer of PEDOT:PSS and the Al cathode has become a main concern for practical applications. To overcome the problems, stable inverted PSCs are widely developed by using metal oxides as buffer layers, e.g., zinc oxide (ZnO) [18-20] and titanium oxide (TiO $_x$ ) [21-23] were widely selected as a cathode buffer layer (CBL), whereas MoO<sub>3</sub> was usually employed as an anode

<sup>1</sup>School of Physics and Electromechnical Engineering, Zhoukou Normal University, Zhoukou 466001, People's Republic of China

Full list of author information is available at the end of the article



buffer layer to replace PEDOT:PSS and to prevent the diffusing of Al atoms into active layers in inverted PSCs [24].

In inverted PSCs, CBLs play a key role of determining device performance. Generally, for efficient PSCs, a good CBL often satisfies several criteria: high transparency, low work function (WF), and favorable energy levels matched well with those of electron acceptors. 1) Hightransparency benefits to large light absorption of active layers, thereby leading to more exciton dissociation at the interface of donor/acceptor and an increase in short current density  $(J_{SC})$ . 2) As reported in previous literatures [25-27], open circle voltage ( $V_{\rm OC}$ ) is determined mostly by the energy-level difference between the highest occupied molecular orbital (HOMO) of the donor and the lowest unoccupied molecular orbital (LUMO) of the acceptor [11,12] and the work function difference of the cathode/anode [25-27], as well as the weight ratio of the donor and acceptor [28]. Low work functions of film could increase the work function difference of the cathode/anode and thus leading to an increase in  $V_{\rm OC}$  of PSCs [25-27]. Afterwards, the films of low WFs facilitate electron collection by cathodes and restrain the charge

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<sup>\*</sup> Correspondence: xdzhou516@163.com

carrier recombination at the interface of the active layer and film [25,27]. 3) Energy levels of the films, matched well with LUMO and HOMO energies of the components of active layers, could effectively select electrons and block holes, leading to an increase in  $J_{SC}$  of PSCs [18-23]. However, is there another factor of the films that has a significant effect on the device performance? Will the contact property of interfaces between active layer droplets and cathode buffer layers be changed when the buffer layer is modified? How will the changes of the interfacial contact property affect the charge carrier mobility and the device performance?

Recently, many films, such as TiO<sub>x</sub> [21-23], ZnO [18-20], cesium oxide (CsO<sub>x</sub>) [29], Ca [30,31], LiF [32], and self-assembled monolayers [18,33], are widely employed to modify the cathode surfaces in inverted PSCs. Among these films, much attention in the development of inverted PSCs has been focused on TiO<sub>x</sub>, which has the advantages of excellent chemical and thermal stability, environmentally friendly, high-electron mobility, and easy fabrication [34]. The  $TiO_x$  film is often prepared by sol-gel synthesis [22], atomic layer deposition [23], and thermal-annealed titanium chelate [16]. Moreover, the film can serve as an effective holeand exciton-blocking layer because of its conduction band of approximately 4.4 eV, which is much higher than the HOMO values of electron acceptor materials [35,36] (seen in Figure 1b). However, challenges still remain for the film, mainly due to the film work function of 4.14 to 4.22 eV [37] still not being low enough for a high  $V_{\rm OC}$  in inverted PSCs. The work function commonly affects the work function of cathode and the work function difference of cathode/anode. Thus, the  $V_{\rm OC}$  of poly(3-hexylthiophene):[6,6]-phenyl-C<sub>61</sub>-butyric acid methyl ester (P3HT:PCBM) inverted PSCs with a  $TiO_x$  film was usually limited to a small range of 0.55 to 0.58 V under simulated 100-mW cm<sup>-2</sup> (AM 1.5 G) solar irradiation [23,38], which blocks its practical application in high-efficiency inverted PSCs.

Besides, a  $CsO_x$  thin film is commonly prepared by evaporating deposition of  $Cs_2CO_3$  particles or spin coating the  $Cs_2CO_3$  solution. Attributed to the  $CsO_x$  is a much lower WF of approximately 2.20 eV as reported in previous literature [27]; it not only can modify the work function of the cathode and cathode buffer layer, but also facilitates electron transportation from electron acceptor materials to the  $CsO_x$  surfaces. Therefore, it is believed that  $CsO_x$  could be an effective cathode buffer layer for PSCs.

In the work, a solution-processed  $CsO_x$  film was inserted at the interface of the active layer/TiO<sub>x</sub>. The MoO<sub>3</sub> film with a thickness of 8 to 10 nm was found to be an optimized value [39]. Here, the Al modified by a 10-nm-thick MoO<sub>3</sub> film was evaporated. By increasing



the work function difference of the cathode/anode, a larger  $V_{OC}$  and an enhanced PCE were achieved in P3HT: indene-C<sub>60</sub> bisadduct (ICBA)-based inverted PSCs and in P3HT:PCBM-based inverted PSCs. First, atomic force microscopy (AFM) measurements present that the double film exhibits a smoother surface with a roughness of just 4.9 nm, as compared with the  $TiO_x$  film and the  $CsO_x$ film. And, the double film provides a better adhesion with P3HT:ICBA blend solutions, evidenced by measurements of solution contact angles, which was found at the interface between P3HT:ICBA blend droplets and the CBLs. Afterwards, it is found that the highest electron mobility  $(\mu_{\rm e})$  of  $5.52 \times 10^{-3}$  cm<sup>2</sup> V<sup>-1</sup>·s<sup>-1</sup> is achieved in inverted electron-only devices with TiO<sub>x</sub>/CsO<sub>x</sub> film measured with space-charge-limited current (SCLC) method. Moreover, current density-voltage (J-V) measurements show that the P3HT:ICBA inverted PSCs and the P3HT:PCBM inverted PSCs with  $TiO_x/CsO_x$  film exhibit a PCE of 5.65% and 3.76%, respectively, under the illumination of AM 1.5, 100 mW cm<sup>-2</sup>, which is higher than that of the PSCs with  $TiO_x$  film and the PSCs with  $CsO_x$  film. The results indicate that the  $TiO_x/CsO_x$  is superior than the  $TiO_x$  and the  $CsO_x$ , not only for the better interfacial contact, but also for the achievement of the higher electron mobility, and thereby leading to an enhanced device performance. Finally, the  $TiO_x/CsO_x$  film possesses many advantages, such as 1) solution processability with ethanol and isopropanol solvents, which promote the application of solution-processing technologies, e.g., spin coating and role-to-role printing and 2) low cost since both  $TiO_x$  and  $CsO_x$  are cheap to produce and commonly used materials in organic photovoltaic and light-emitting fields, which suggests their huge potential for practical applications.

#### Methods

P3HT (4002-E) and PCBM were purchased from Rieke Metals Inc. (Lincoln, NE, USA) and Nano-C (Westwood, MA, USA), respectively. Indene- $C_{60}$  bisadduct was purchased from Solarmer Inc. (El Monte, CA, USA). The TiO<sub>x</sub> film was prepared by spin coating TiO<sub>x</sub> sol-gel solution [22] on fluorinated tin oxide (FTO) substrate and then was thermally treated at 200°C for 30 min in air. Whereas, the CsO<sub>x</sub> film was prepared by spin coating isopropanol solution of Cs<sub>2</sub>CO<sub>3</sub> on FTO substrate and then thermal annealing at 160°C for 10 min in a glove box filled with Ar atmosphere. When spin coating the Cs<sub>2</sub>CO<sub>3</sub> solution on FTO/TiO<sub>x</sub> substrate and then thermal annealing at 160°C for 10 min, it forms the TiO<sub>x</sub>/CsO<sub>x</sub> film.

All the inverted PSCs were fabricated on FTO-coated glass. First, the different film was spin coated and then baked on FTO. Then, the blend solution of P3HT:PCBM and P3HT:ICBA in dichlorobenzene (1:1, w/w, 36 mg ml<sup>-1</sup>) was spin coated at 800 rpm. The active layers were then placed into glass petri dishes to undergo solvent annealing and annealed at 150°C for 10 min on a hot plate in a glove box. Subsequently, MoO<sub>3</sub> (10 nm) and Al (100 nm) were evaporated as an anode buffer layer and anode, respectively, under the pressure of  $\leq 1.0 \times 10^{-4}$  Pa. Transmittance spectra were taken on a Hitachi U-3010 UV-visible spectrophotometer (Hitachi, Ltd., Chiyoda-ku, Japan). The surface morphology of active layers was characterized by AFM (SPM-9500J3, Shimadzu, Kyoto, Japan). The J-V measurement of the inverted PSCs was conducted on a computer-controlled Keithley 236 Source Measure Unit (Keithley Instruments, Inc., Cleveland, OH, USA). Device characterization was carried out in a glove box under illumination of AM 1.5 G, 100 mW cm<sup>-2</sup> using a xenon-lamp-based solar simulator (from Newport Co., LTD., Irvine, CA, USA).

#### **Results and discussion**

To investigate the effect of the cathode buffer layers on the performance of the inverted PSCs, we designed six types of inverted PSC devices with different structures:

- (A). FTO/CsO<sub>x</sub>/P3HT:ICBA (200 nm)/MoO<sub>3</sub> (10 nm)/Al (100 nm),
- (B). FTO/TiO<sub>x</sub>(80 nm)/P3HT:ICBA (200 nm)/MoO<sub>3</sub> (10 nm)/Al (100 nm),
- (C). FTO/TiO<sub>x</sub>(80 nm)/CsO<sub>x</sub>/P3HT:ICBA (200 nm)/MoO<sub>3</sub> (10 nm)/Al (100 nm),
- (D). FTO/CsO<sub>x</sub>/P3HT:PCBM (200 nm)/MoO<sub>3</sub> (10 nm)/Al (100 nm),
- (E). FTO/TiO<sub>x</sub> (80 nm)/P3HT:PCBM (200 nm)/MoO<sub>3</sub> (10 nm)/Al (100 nm),
- (F). FTO/TiO<sub>x</sub>(80 nm)/CsO<sub>x</sub>/P3HT:PCBM (200 nm)/MoO<sub>3</sub> (10 nm)/Al (100 nm).

#### Device performance

Figure 2a shows the *J*-*V* characteristic curves of the P3HT: ICBA inverted PSCs with a film of  $TiO_x$ ,  $CsO_x$ , and  $TiO_x/CsO_x$  under simulated AM 1.5 G solar illumination of 100 mW cm<sup>-2</sup>. For comparison, more than 30 solar cells were fabricated and characterized to confirm the performance trends. It presents that the inverted PSCs with  $CsO_x$  film (devices A) show a relatively poor PCE of 4.91%



with  $V_{\rm OC}$  of 0.82 V,  $J_{\rm SC}$  of 9.79 mA cm<sup>-2</sup>, and fill factor (FF) of 61.2%. Compared with the devices A, the PSCs with TiO<sub>x</sub> film (devices B) yield an equipotent PCE of 4.95%, with a lower  $V_{\rm OC}$  of 0.76 V, a higher  $J_{\rm SC}$  of 10.82 mA cm<sup>-2</sup>, and a *FF* of 60.2%. It is considered that the higher  $J_{SC}$  of 10.82 mA cm<sup>-2</sup> is attributed to the exciton- and hole-blocking ability of the TiO<sub>x</sub> film resulted from its favorable conduction band, as shown in Figure 1b. For the PSCs with the  $TiO_x/CsO_x$  film (devices C), the highest PCE of 5.65% is achieved with  $V_{\rm OC}$ of 0.84 V,  $J_{SC}$  of 10.95 mA cm<sup>-2</sup>, and FF of 61.4%, demonstrating a good combination of  $TiO_x$  and  $CsO_x$ , which compensates the loss in  $V_{\rm OC}$  of devices B as well as in  $J_{\rm SC}$  of devices A, respectively. Such photovoltaic performance parameters of the inverted PSCs are summarized in Table 1.

To further investigate the general suitability of the  $TiO_x/CsO_x$  film in inverted PSCs, the other electron acceptor material of PCBM was used instead of ICBA for fabricating P3HT:PCBM inverted PSCs. The J-V characteristic curve is shown in Figure 2b. As expected, for the inverted PSCs with CsO<sub>x</sub> film (devices D), a PCE of 3.41% is achieved with  $V_{\rm OC}$  of 0.58 V,  $J_{\rm SC}$  of 9.86 mA cm<sup>-2</sup>, and FF of 59.6%. Compared with that of the devices D, the PCE and FF of the inverted PSCs with  $TiO_x$  film (devices E) just change a little, whereas the  $J_{SC}$  is enhanced significantly from 9.86 to 10.63 mA  $\rm cm^{-2}$  and the  $V_{\rm OC}$ drops severely from 0.58 to 0.55 V. The inverted PSCs with  $TiO_x/CsO_x$  film (devices F) exhibit a PCE of 3.76%, better than that of the devices D and the devices E, which may be due to more electron extraction from the P3HT: PCBM active layer to the FTO cathode. Note that compared with the devices D, the devices E yield an enhanced short-circuit current, maybe due to a better holetransporting and electron-blocking property of the TiO<sub>x</sub> than that of the  $CsO_x$ . When  $TiO_x/CsO_x$  was used as a cathode buffer layer, it did not induce an increase in  $J_{SC}$ ; however, a significant increase in  $V_{\rm OC}$  from 0.76 to 0.84 V was observed clearly, attributed to the insert of CsO<sub>x</sub> film with a low work function. The changes in  $J_{SC}$  and  $V_{OC}$  of the P3HT:PCBM inverted PSCs agree with those of the P3HT:ICBA inverted PSCs.

#### Optical properties and surface morphology of the films

Figure 3 shows the optical transmittance of  $CsO_x$ ,  $TiO_x$ , and  $TiO_x/CsO_x$  on FTO substrates. The  $CsO_x$  film is highly transparent in the visible range, and the minimum light transmittance is not less than 90% between 400 and 800 nm. Compared with the  $CsO_x$  film on FTO substrate, the  $TiO_x$  film exhibits a decreased optical transmittance in the range of 300 to 800 nm, whereas the  $TiO_x/CsO_x$  has a decrease optical transmittance of 350 to 450 nm, as compared with the  $TiO_x$ , suggesting an ultra-thin film of  $CsO_x$  on the  $TiO_x$  surface.

To investigate the surface morphology of FTO modified by the film, atomic force microscopy measurements were carried out. Figure 4 shows the surface images of the four samples, including the FTO substrate, TiO<sub>x</sub>, CsO<sub>x</sub>, and  $TiO_x/CsO_x$  film on FTO substrate. It presents that the FTO substrate without any modification by CsO<sub>x</sub> or TiO<sub>x</sub> shows a lot of large 'valleys' and the root mean square (RMS) is about 15.7 nm. After spin coating  $Cs_2O_3$  solution on the FTO substrate and then thermal annealing, it forms a  $CsO_x$  thin film, which exhibits a lower RMS of 12.5 nm; however, there is not any apparent change in surface morphology between the FTO and the CsO<sub>x</sub>modified FTO. Due to the modification of TiO<sub>x</sub> on FTO substrate, the  $TiO_x$  film exhibits a decreased RMS of about 7.6 nm. Moreover, it shows smaller 'valleys' on the surface and becomes much smoother than the CsO<sub>x</sub> film, whereas the  $TiO_x/CsO_x$  film presents a RMS of just 4.9 nm, indicating the  $CsO_x$  combines well with the TiO<sub>v</sub> film.

Note that it is difficult to directly measure the thickness of the  $CsO_x$  film on the top of  $TiO_x$  film because the thickness of the  $CsO_x$  film is much smaller than the RMS of either the FTO substrate or the  $TiO_x$  film. However, the varieties of surface morphology in the four samples have been probed by AFM measurements, implying the presence of the  $CsO_x$  layer on FTO substrates as well as  $TiO_x$ -modified FTO substrates.

#### Droplet contact angle measurements

Due to the device performance being significantly dependent on the interfacial contact property of the

Table 1 Summary of performance of the P3HT:ICBA inverted PSCs and the P3HT:PCBM inverted PSCs with different film

Device	V <sub>oc</sub> (V)	J <sub>SC</sub> (mA cm <sup>-2</sup> )	FF (%)	PCE (%)	Contact angle (°)	μ <sub>e</sub> (cm <sup>2</sup> V <sup>-1</sup> ·s <sup>-1</sup> )
CsO <sub>x</sub> <sup>a</sup>	0.82	9.79	61.2	4.91	24.5 ± 0.5	$3.85 \times 10^{-3}$
TiOxª	0.76	10.82	60.2	4.95	32.0 ± 2.0	$5.00 \times 10^{-3}$
TiO <sub>x</sub> /CsO <sub>x</sub> <sup>a</sup>	0.84	10.95	61.4	5.65	$21.0 \pm 0.5$	$5.52 \times 10^{-3}$
CsO <sub>x</sub> <sup>b</sup>	0.58	9.86	59.6	3.41	_	—
TiOx <sup>b</sup>	0.55	10.63	57.3	3.35	_	—
TiO <sub>x</sub> /CsO <sub>x</sub> <sup>b</sup>	0.59	10.81	59.0	3.76	—	—

<sup>a</sup>PSCs based on P3HT:ICBA; <sup>b</sup>PSCs based on P3HT:PCBM.





film/active layer [40], which contributes to surface energy, it is necessary to observe the surface energy of the film. In this work, the surface energy of the film is studied with measurements of solution contact angles between a drop of P3HT:ICBA solution and the different film. For observing distinctly the interfacial contact angles, we used directly the P3HT and ICBA blend solution (1:1, w/w, 36 mg ml<sup>-1</sup>) in dichlorobenzene as the 'solution' and measured the contact angles between the solution drop and the different film. Figure 5 shows the droplet images of P3HT:ICBA solutions on FTO substrate,  $CsO_x$ ,  $TiO_x$ , and  $TiO_x/CsO_x$  film, respectively. It presents that the contact angle of the FTO

surface to the P3HT:ICBA blend solution is  $46.5^{\circ} \pm 2.5^{\circ}$ , indicating a poor binding of the blend droplet to the FTO surface. Moreover, compared with the droplet on the FTO substrate, the smaller contact angle of  $32.0^{\circ} \pm 2.0^{\circ}$  and  $24.5^{\circ} \pm 0.5^{\circ}$  is observed for the droplet on the TiO<sub>x</sub> and the CsO<sub>x</sub> film, respectively, indicating a better wetting of the solvent, whereas the blend droplet has the smallest contact angle of just  $21.0^{\circ} \pm 0.5^{\circ}$  to the TiO<sub>x</sub>/CsO<sub>x</sub> film, suggesting the best affinity of the P3HT:ICBA active layer to the TiO<sub>x</sub>/CsO<sub>x</sub> film, which will be electrically/energetically favorable to the electron extraction and hence facilitates the fabrication of efficient inverted PSCs [29].

The RMS value of the TiO<sub>x</sub>, CsO<sub>x</sub>, and TiO<sub>x</sub>/CsO<sub>x</sub> is 12.5, 7.6, and 4.9 nm, respectively, and the corresponding P3HT:ICBA solution contact angle is  $32.0^{\circ} \pm 2.0^{\circ}$ ,  $24.5^{\circ} \pm 0.5^{\circ}$ , and  $21.0^{\circ} \pm 0.5^{\circ}$ , respectively, suggesting that the contact angle decreases with the decrease of the RMS value. The change of the solution contact angle is partially resulted from the morphology variation induced by the CsO<sub>x</sub> modification. In the work, the factor of RMS alters the interfacial contact angles and induces an enhancement of wetting and adhesion by changing surface energy, as also reported in previous literature [40].

#### **Electron mobility measurements**

The electron-extraction ability by the different film may be significantly dependent on the interface contact property and the energy-level alignment. To precisely assess the correlation among the factors, we have carefully examined the  $\mu_{e}$  of electron-only devices with different





film by using the SCLC method. In the work, the electrononly devices with an architecture of ITO/CBL/P3HT: ICBA/CsO<sub>x</sub>/Al were fabricated to measure the  $\mu_{e}$ . In such electron-only devices, the TiO<sub>x</sub>, CsO<sub>x</sub>, and TiO<sub>x</sub>/CsO<sub>x</sub> is used as a CBL, whereas the CsO<sub>x</sub> layer on the active layer surface is employed as a hole-blocking layer. Note that it is spin coated with Cs<sub>2</sub>CO<sub>3</sub> solution and then thermally annealed for 160°C for 10 min in glove box filled with Ar. Generally, high performance of PSCs commonly accompanies with a high-electron mobility, which is mainly influenced by exciton dissociation, as well as charge-carrier recombination at the interfaces of donor/acceptor and the interfaces of CBL/acceptor. The single-carrier mobility can be obtained from the  $J_{SCLC}$ - $V^2$  curve (Figure 6) by the SCLC method using the Mott-Gurney square law [41]:

$$J_{\rm SCLC} = \frac{9}{8} \varepsilon_r \varepsilon_0 \mu \frac{V^2}{L^3} \tag{1}$$



where  $\varepsilon_r$  is the dielectric constant of the material;  $\varepsilon_0$  is the permittivity of free space; L is the distance between the cathode and anode, which is equivalent to the film thickness; and V is the applied voltage. Figure 6 shows the SCLC curves of the P3HT:ICBA-based electron-only devices with different film. It demonstrates the corresponding relationship of  $J_{SCLC}$  with  $V^2$ , where  $J_{SCLC}$  is the dark current density. The  $\mu_e$  of the devices with CsO<sub>x</sub> film is only  $3.85 \times 10^{-3}$  cm<sup>2</sup> V<sup>-1</sup>·s<sup>-1</sup>. Compared with the device with a  $CsO_x$  film, however, the devices with  $TiO_x/CsO_x$  film show an enhanced remarkable  $\mu_e$ of  $5.52 \times 10^{-3}$  cm<sup>2</sup> V<sup>-1</sup> s<sup>-1</sup>, suggesting an enhanced electron-extraction ability by the  $TiO_x/CsO_x$  film and hence leading to the enhancement in  $J_{SC}$  and PCE of the inverted PSCs. It should be noted that the  $\mu_e$  values of the inverted PSCs were higher than those of normal PSCs in previous work [42]. The data are summarized in Table 1. In the work, the increase of the  $\mu_e$  should be also related to the reduction in work function of the  $TiO_x$  surface modified by  $CsO_x$ . Li et al. reckoned that a thin layer of  $CsO_x$  is capable of lowering the work function of the underlying layer of ITO [27]. Moreover, Xu et al. reported inverted PSCs with a component film of Cs<sub>2</sub>CO<sub>3</sub>:4,7-Diphenyl-1,10-phenanthroline (BPhen) [43]. The work function of pristine BPhen on the ITO substrate was determined to be 3.1 eV by ultraviolet photoelectron spectroscopy, while the corresponding work function of the Cs<sub>2</sub>CO<sub>3</sub>:BPhen component layer was reduced to about 2.6 eV, thereby leading an increase in  $V_{\rm OC}$ from 0.40 to 0.64 V and  $J_{SC}$  from 7.3 to 9.4 mA cm<sup>-2</sup> of inverted PSCs with Cs2CO3:BPhen film as compared to inverted PSCs with BPhen film [43]. Combining all the above and our mentioned results, it is believed that the  $CsO_x$  (or  $Cs_2CO_3$ )-modified film can reduce the WF of the film and provide a better wetting property of the blend solvent on the  $TiO_x/CsO_x$  film surface, as well as a favorable energy-level alignment, which facilitate electron

injection from electron acceptor to cathode, and thus leading to a remarkable improvement in  $V_{\text{OC}}$  and  $J_{\text{SC}}$ .

#### Conclusions

In summary, high-efficiency inverted polymer solar cells are demonstrated with a solution-processed  $\text{TiO}_x/\text{CsO}_x$ layer as a cathode buffer layer. By inserting a  $\text{CsO}_x$  film at the interface of the  $\text{TiO}_x/\text{active layer}$ , the power conversion efficiency up to 5.65% and 3.76% has been achieved in inverted PSCs with P3HT:ICBA and inverted PSCs with P3HT:PCBM, respectively, under 100-mW cm<sup>-2</sup> AM 1.5 G simulated solar illumination, suggesting that the  $\text{TiO}_x/\text{CsO}_x$  is superior than the  $\text{TiO}_x$  and the  $\text{CsO}_x$ . Moreover, this work not only provides a new option for the selection of the solution-processed cathode buffer layer in designing efficient and stable inverted PSCs, but also presents that the improvement of the interface contact property is also an essential factor for efficient polymer solar cells when preparing cathode buffer layers.

#### **Competing interests**

The authors declare that they have no competing interests.

#### Authors' contributions

XZ and XF designed the experiments and carried out the synthesis and characterization of the samples. XZ analyzed the results and wrote the first draft of the manuscript. XF and XS participated in analyses of the results and discussion of this study. YZ and ZZ revised the manuscript and corrected the English. All authors read and approved the final manuscript.

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#### Author details

<sup>1</sup>School of Physics and Electromechnical Engineering, Zhoukou Normal University, Zhoukou 466001, People's Republic of China. <sup>2</sup>Hubei Collaborative Innovation Center for Advanced Organic Chemical Materials, Faculty of Physics and Electronic Science, Hubei University, Wuhan 430062, People's Republic of China.

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